

承 認 書 SPECIFICATION FOR APPROVAL

Shenzhen Maidongshidai Technology Co., LTD

客戶名稱 401, Building 3, No.128, Shunfeng Road, Zhongxin Community,

CUSTOMER: Pingdi Street, Longgang District, Shenzhen, China

客戶料號

CUSTOMER'S P/N:

料號

PART NUMBER : WAN3216F245H08

規格

DESCRIPTION : Chip Antenna 3216 L Ant 2.45G Type H08

版本

VERSION : V1.1

日期

ISSUE DATE : 2020/02/27

客戶承認	
CUSTOMER APPROVED	

工 程 部 R&D CENTER				
承 認 確 認 APPROVAL CHECKED		製 作 DRAWN		
Ray	Tennyson	Snow		





萬誠科技股份有限公司

11261 台北市北投區立功街 151 號 1 樓

電話: (02) 2898-2220 傳真: (02) 2898-5055

OneWave Electronic Co., Ltd.

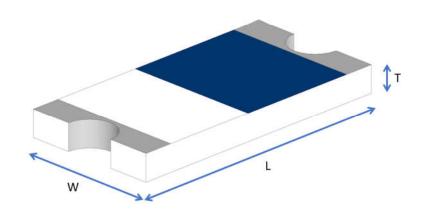
1F, No. 151, Li Gong Street, Beitou District, Taipei City 11261, Taiwan

TEL: +886 2 2898-2220 FAX: +886 2 2898-5055



3216 Chip antenna

For Bluetooth / WLAN Applications



P/N: WAN3216F245H08

	Dimension (mm)	
L	3.23 ± 0.20	
W 1.66 ± 0.20		
Т	0.45 ± 0.20	



Part Number Information

WAN 3216 F 245 H 08
A B C D E F

Α	Product Series	Antenna
В	Dimension L x W	3.2 x 1.6mm (±0.2mm)
C	Material	High K material
D	Working Frequency	2.4 ~ 2.5GHz
E	Feeding mode	PIFA & Single Feeding
F	Antenna type	Type = 08

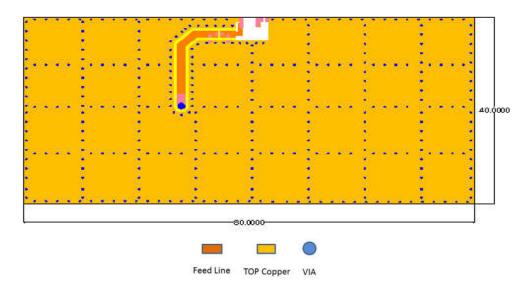
1. Electrical Specification

Specification			
Part Number	WAN3216F245H08		
Central Frequency	2450	MHz	
Bandwidth	120 (Min.)	MHz	
Return Loss	-6.5 (Max)	dB	
Peak Gain	1.75	dBi	
Impedance	50	Ohm	
Operating Temperature	-40~+110	°C	
Maximum Power	4	W	
Resistance to Soldering Heats	10 (@ 260°C)	sec.	
Polarization	Linear		
Azimuth Beamwidth	Omni-directional		
Termination	Ni / Au (Leadless)		

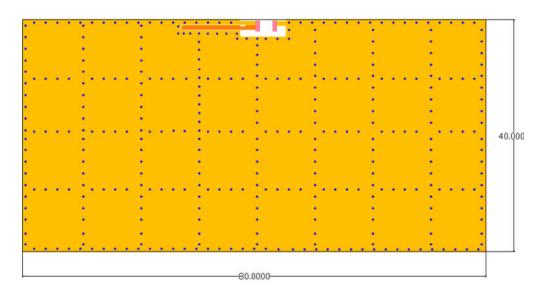
Remark: Bandwidth & Peak Gain was measured under evaluation board of next page



2. Recommended PCB Pattern Evaluation Board Dimension



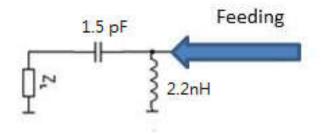
2nd Evaluation Board Dimension



Suggested Matching Circuit

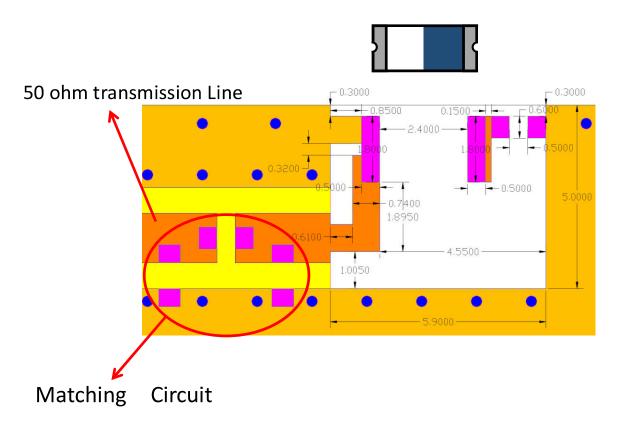
重要資訊:

匹配元件建議使用精準度高的電威±0.1~0.3nH、電容±0.1pF

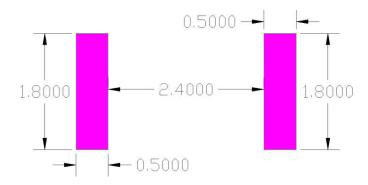




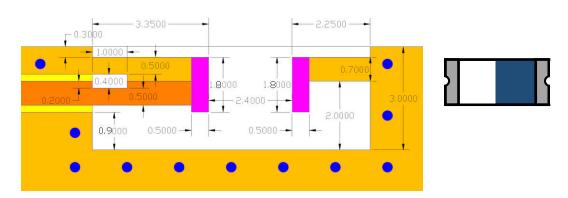
Layout Dimensions in Clearance area(Size=5.9*5.0mm)



FootPrint (Unit:mm)

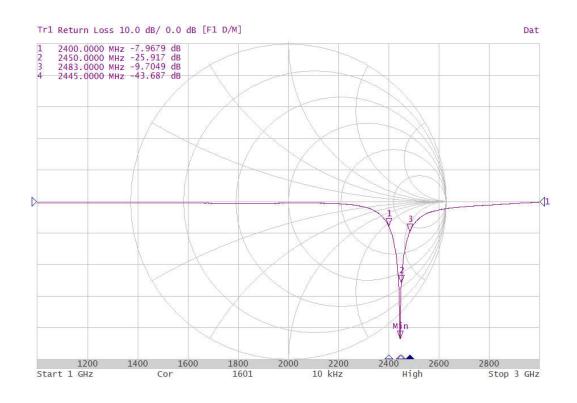


◆ 2nd Layout Dimensions in Clearance area(Size=8.0*3.0mm)



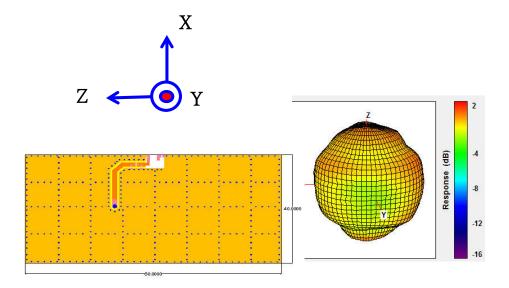


3. Measurement Results Return Loss



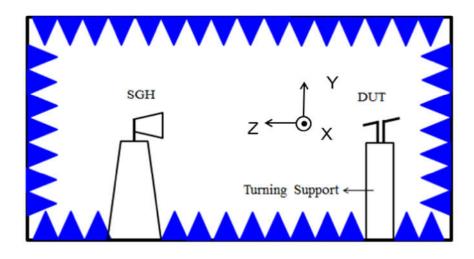


Radiation Pattern



	Efficiency	Peak Gain	Directivity
2400MHz	81.46%	1.67 dBi	2.56 dBi
2450MHz	84.75%	1.75 dBi	2.46 dBi
2500MHz	82.68%	1.70 dBi	2.52 dBi

Chamber Coordinate System





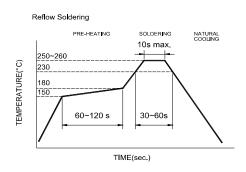
4. Reliability and Test Condictions

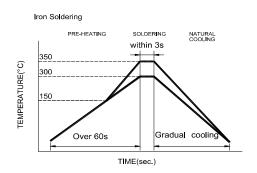
ITEM	REQUIREMENTS	TEST CONDITION		
Solderability	Wetting shall exceed 90% coverage Ne visible mechanical damage.	Pre-heating temperature:150°C/60sec.		
	2. No visible mechanical damage	Solder temperature:230±5°C		
	TEMP (℃)	Duration:4±1sec.		
		Solder:Sn-Ag3.0-Cu0.5		
	230°C 4±1 sec.	Flux for lead free: rosin		
	150℃			
	60sec			
	/ ousec \			
Solder heat	No visible mechanical damage	Do lastinatana 450°C/C0		
Resistance	2. Central Freq. change :within ± 6%	Pre-heating temperature:150 $^{\circ}$ C/60sec. Solder temperature:260 \pm 5 $^{\circ}$ C		
		Duration:10±0.5sec.		
	TEMP (°C)	Solder:Sn-Ag3.0-Cu0.5		
	260°C 10±0.5 sec.	Flux for lead free: rosin		
	150℃			
	60sec			
	<i>y</i> 33335 \			
Component	No visible mechanical damage	The device should be reflow		
Adhesion	1. No visible mechanical damage	soldered(230±5°C for 10sec.) to a tinned		
(Push test)		copper substrate A dynometer force		
		gauge should be applied the side of the		
		component. The device must with-ST-F		
		0.5 Kg without failure of the termination		
Component	No visible mechanical damage	attached to component. Insert 10cm wire into the remaining open		
Component Adhesion		eye bend ,the ends of even wire lengths		
(Pull test)		upward and wind together.		
(i dii test)		Terminal shall not be remarkably		
		damaged.		
Thermal shock	1. No visible mechanical damage	+110°C=>30±3min		
	2. Central Freq. change :within ±6%	-40°C =>30±3min		
		Test cycle:10 cycles		
	Phase Temperature(°C) Time(min)	The chip shall be stabilized at normal		
	1 +110±5°C 30±3	condition for 2~3 hours before		
	2 Room Within	measuring.		
	Temperature 3sec			
	3 -40±2°C 30±3			
	4 Room Within			
	Temperature 3sec			
Resistance to	No visible mechanical damage	Temperature: +110±5°C		
High	2. Central Freq. change :within ±6%	Duration: 1000±12hrs		
Temperature	No disconnection or short circuit.	The chip shall be stabilized at normal		
	5. NO disconnection of short circuit.	condition for 2~3 hours before		
		measuring.		
Resistance to	1. No visible mechanical damage	Temperature:-40±5°C		
Low	2. Central Freq. change :within ±6%	Duration: 1000±12hrs		
Temperature	3. No disconnection or short circuit.	The chip shall be stabilized at normal		
	5. He disconnection of short official.	condition for 2~3 hours before		
		measuring.		
Humidity	1. No visible mechanical damage	Temperature: 40±2°C		
	2. Central Freq. change :within ±6%	Humidity: 90% to 95% RH		
	3. No disconnection or short circuit.	Duration: 1000±12hrs		
	The second of short off on the	The chip shall be stabilized at normal		
		condition for 2~3 hours before		
		measuring.		



5. Soldering and Mounting

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.





Recommended temperature profiles for re-flow soldering in Figure 1.

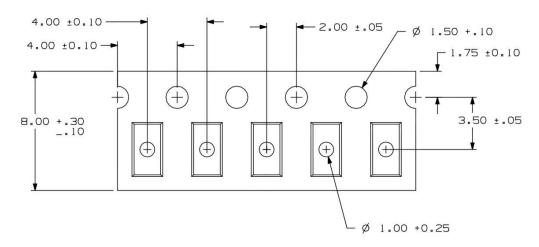
Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

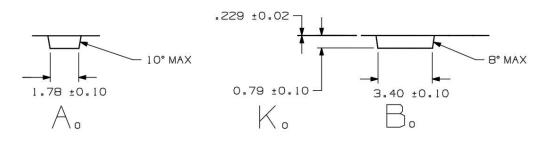
- Preheat circuit and products to 150[°]C
- Never contact the ceramic with the iron tip
- Use a 20 watt soldering iron with tip diameter of 1.0mm
- 280°C tip temperature (max)
- 1.0mm tip diameter (max)
- · Limit soldering time to 3 sec.



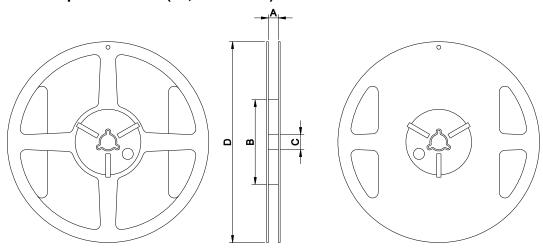
6.Packaging Information

Tape Specification:





Reel Specification: (7", Ф180 mm)



7" x 8 mm

Tape Width(mm)	A(mm)	B(mm)	C(mm)	D(mm)	Chip/Reel(pcs)
8	9.0±0.5	60±2	13.5±0.5	178±2	3000



7. Storage and Transportation Information

Storage Conditions

To maintain the solderability of terminal electrodes:

- 1. Temperature and humidity conditions: -10~ 40° and 30~70% RH.
- 2. Recommended products should be used within 6 months from the time of delivery.
- 3. The packaging material should be kept where no chlorine or sulfur exists in the air.

Transportation Conditions

- 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.